

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/500,684	PIENA, MARTINUS JOHANNES	
Examiner	Art Unit	
Hai L. Nguyen	2816	

	SEAR	CHED	
Class	Subclass	Date	Examiner
327	31,165, 166,170, 261,263, 264	6/15/2005	HLN
	276-278		
	284,285		1,
V	427	V	V
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INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Shepardize Search	6/16/2005	HLN
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